Se	arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/638,421	OCHI ET AL.
Examiner	Art Unit
Tu X. Nguyen	2618

	SEARCHED				
Class	Subclass	Date	Examiner		
455	7,11.1	6/30/2006			
	13.1				
	16				
	511				
	423				
	15				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		7 - 3		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Search East	6/30/2006	TN	